

**16-CHANNEL (4 BANKS OF 4-CHANNEL)
HIGH-VOLTAGE ANALOG SWITCH**

The ABLIC Inc. HDL6M06502B is 16-channel high-voltage analog switch IC operated only by a single 5V for ultrasound imaging applications.

The HDL6M06502B consists of 4 sets of 4 single-pole, single-throw (SPST) analog switches controlled by 4 logic inputs. The HDL6M06502B has a unique pin-out which makes PCB traces easier.

Functions

- 16-channel (4 banks of 4-channel) high-voltage SPST analog switch with active ground clamp

Features

- 0V to $\pm 100V$ analog signal voltage range (10kHz to 20MHz signal frequency range)
- 2A peak analog signal current per channel
- 8Ω main switch on-resistance
- $40k\Omega$ bleed resistor on probe side
- Low on/off-capacitance
- -52dB off-isolation at 5MHz (load-independent)
- -60dB switch crosstalk
- 20Ω ground clamp switch on probe side alternately turned on/off with main switch
- DS_ASW to disable 20Ω ground clamp switch
- 1.8V to 5V CMOS logic interface
- Single +5V power supply (NO HIGH-VOLTAGE POWER SUPPLY required)
- Low power dissipation (static 1mW)
- Unique pin configuration for easy PCB traces (SPs on one side and STs on opposite side)
- 52-lead 8x8mm QFN package (RoHS compliant)

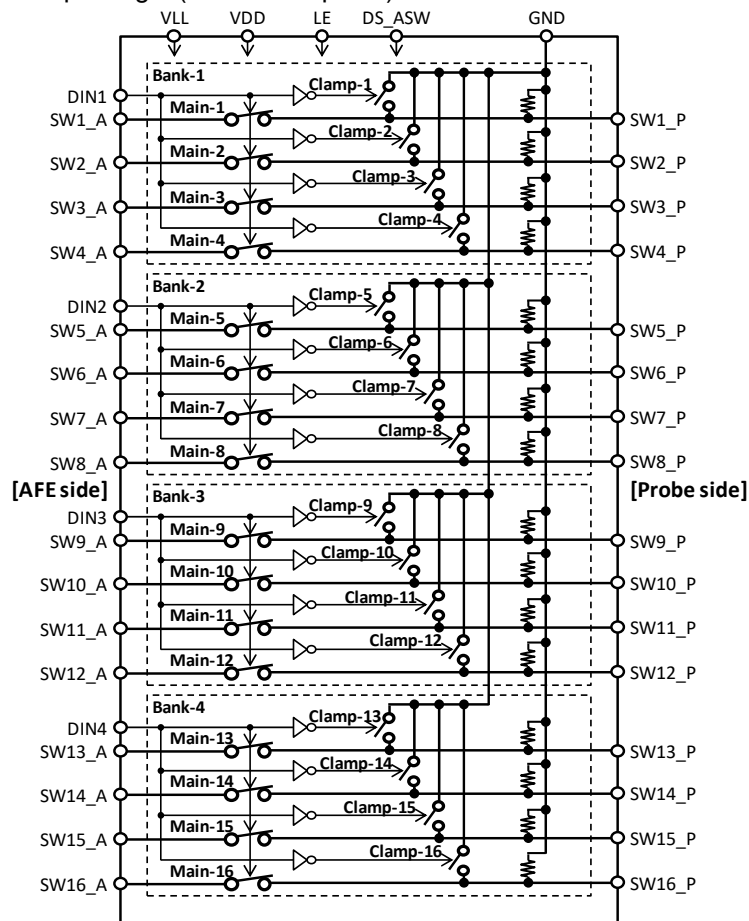


Fig.1 Block diagram
ABLIC Inc.

1. Absolute Maximum Ratings

T_A=25°C unless otherwise noted.

Table 1 Absolute Maximum Ratings

| No. | Items | Symbol | Value | Units | Condition |
|-----|--|---------------------|--------------|-------|-----------|
| 1 | Positive logic supply voltage | V _{LL} | -0.4 to +7 | V | |
| 2 | Positive supply voltage | V _{DD} | -0.4 to +7 | V | |
| 3 | Logic input voltage (x=1~4) | DINx, LE, DS_ASW | -0.4 to +7 | V | |
| 4 | Analog signal range | V _{SIG} | -105 to +105 | V | |
| 5 | Peak analog signal current per channel | I _{SW} | 2.5 | A | |
| 6 | Operating junction temperature | T _{Jop} | -20 to +150 | °C | |
| 7 | Storage temperature | T _{STG} | -55 to +150 | °C | |
| 8 | Maximum power dissipation | P _{Dmax} | 4 | W | |

NOTE: * Stresses beyond the absolute maximum ratings may cause permanent damage to the product.

2. Operating Supply Voltages, Logic Inputs, and Application Circuits

2.1 Operating Supply Voltages, Temperature, and Logic Inputs

Table 2 Operating Supply Voltages and Logic Inputs

| No | Items | Symbol | Min | Typ | Max | Units | Condition |
|----|--------------------------------|------------------|--------------------|----------|--------------------|-------|-----------------------------|
| 1 | Logic supply voltage | V _{LL} | 1.7 | 1.8 to 5 | V _{DD} | V | |
| 2 | Positive supply voltage | V _{DD} | 4.75 | 5 | 5.25 | V | |
| 3 | IC substrate voltage *1 | V _{SUB} | - | 0 | - | V | |
| 4 | Operating free-air temperature | T _A | 0 | | 75 | °C | |
| 5 | High-level logic input voltage | V _{IH} | 0.8V _{LL} | - | V _{LL} | V | |
| 6 | Low-level logic input voltage | V _{IL} | 0 | - | 0.2V _{LL} | V | |
| 7 | Logic input high current *2 | I _{IH} | -10 | - | 10 | μA | DINx (x=1~4), LE, DS_ASW |
| 8 | Logic input low current | I _{IL} | -10 | - | 10 | μA | |
| 9 | Logic input capacitance | C _{IN} | - | 2 | - | pF | |
| 10 | Setup time | t _{SU} | 20 | - | - | ns | |
| 11 | Hold time | t _{HLD} | 20 | - | - | ns | |
| 12 | LE time width | t _{LEW} | 20 | - | - | ns | |

NOTE:

*1) Thermal pad on the bottom of the package must be soldered to the ground.

*2) DS_ASW has 100μA leakage at V_{LL}=5V due to 50kΩ internal pull-down resistor.

2.2 Power Supply Sequencing

No power supply sequencing is required even if V_{LL} is different from V_{DD}.
Please apply the V_{DD} voltage to the V_{LL} when operating with a single 5V.

2.3 Application Circuits

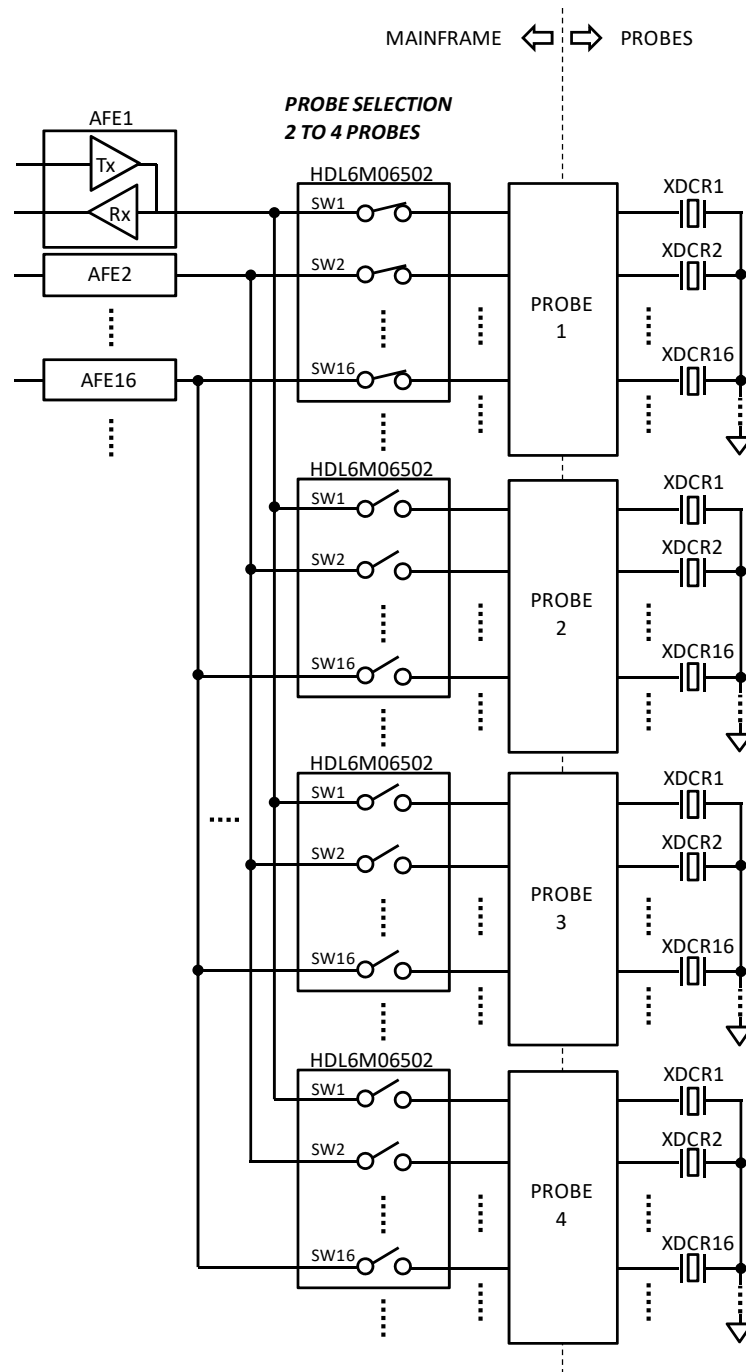


Fig.2 Probe selection (2 to 4 probes) in ultrasound imaging application

3. Electrical Characteristics

DC Characteristics

Table 3 DC Characteristics

$V_{LL}=3.3V$, $V_{DD}=5V$, $LE=0$, $DS_ASW=0$, $T_A=25^{\circ}C$, unless otherwise specified.

| No. | Items | Symbol | Spec | | | Units | Conditions |
|-----|---|------------------|------|-----|------|------------|---|
| | | | Min | Typ | Max | | |
| 1 | Analog signal range | V_{SIG} | -100 | - | +100 | V | |
| 2 | V_{LL} quiescent current | I_{LLQ} | - | 0.1 | - | μA | Quiescent current-1 All main switches off |
| 3 | V_{DD} quiescent current | I_{DDQ} | - | 250 | - | μA | |
| 4 | V_{LL} quiescent current | I_{LLQ} | - | 0.1 | - | μA | Quiescent current-2 All main switches on |
| 5 | V_{DD} quiescent current | I_{DDQ} | - | 250 | - | μA | |
| 6 | V_{LL} dynamic current | I_{LL} | - | 0.4 | 1 | μA | Dynamic current All channels switching simultaneously at $f_{sw}=50kHz$ |
| 7 | V_{DD} dynamic current | I_{DD} | - | 1.6 | 2 | mA | |
| 8 | DC offset main switch off | V_{OS} | - | 0 | - | mV | |
| 9 | Small signal main switch on-resistance | R_{ONS} | - | 8 | 10 | Ω | $V_{SIG}=0.1V_{pp}$ to $5V_{pp}$ @5MHz, $R_S=10\Omega$ |
| 10 | Small signal main switch on-resistance matching | ΔR_{ONS} | - | 2 | 5 | % | $V_{SIG}=0V$, $I_{SIG}=5mA$ |
| 11 | Large signal main switch on-resistance | R_{ONL} | - | 8 | - | Ω | $V_{SIG}=20V_{pp}@5MHz$, $R_S=10\Omega$ |
| 12 | GND clamp on-resistance | R_{ONCL} | - | 20 | - | Ω | Main switches off, probe side |
| 13 | Shunt resistance | R_{BLD} | 30 | 40 | 50 | k Ω | Probe side |
| 14 | Switch output peak current | I_{SW} | - | 2 | - | A | 100ns pulse, 0.1% duty cycle |

AC Characteristics

Table 4 AC Characteristics

$V_{LL}=3.3V$, $V_{DD}=5V$, $LE=0$, $DS_ASW=0$, $T_A=25^{\circ}C$, unless otherwise specified.

| No. | Items | Symbol | Spec | | | Units | Conditions |
|-----|----------------------------|----------------|------|-----|-----|---------|--|
| | | | Min | Typ | Max | | |
| 1 | Turn-on time | t_{ON} | - | 2 | 5 | μs | |
| | | t_{ON_ASW} | - | 2 | 5 | μs | |
| 2 | Turn-off time | t_{OFF} | - | 2 | 5 | μs | |
| | | t_{OFF_ASW} | - | 2 | 5 | μs | |
| 3 | Output switching frequency | f_{SW} | - | - | 50 | kHz | Duty cycle=50% |
| 4 | Small signal frequency | f_{SIG} | 0.01 | - | 20 | MHz | $C_L=220pF$ |
| 5 | Off isolation | V_{ISO} | - | -49 | - | dB | $f_{SIG}=5MHz$, $R_L/C_L=1k\Omega/15pF$ |
| | | | - | -52 | - | dB | $f_{SIG}=5MHz$, $R_L=50\Omega$ |
| 6 | Crosstalk | V_{CT} | - | -60 | - | dB | $f_{SIG}=5MHz$, $R_L=50\Omega$ |
| 7 | Off capacitance to GND | C_{OFF} | - | 30 | - | pF | $V_{SIG}=0V$, $f_{SIG}=1MHz$ |
| 8 | On capacitance to GND | C_{ON} | - | 15 | - | pF | $V_{SIG}=0V$, $f_{SIG}=1MHz$ |
| 9 | Output spike voltage | V_{SPK} | -10 | 90 | 150 | mV | 50 Ω load |

4. Logic Timing

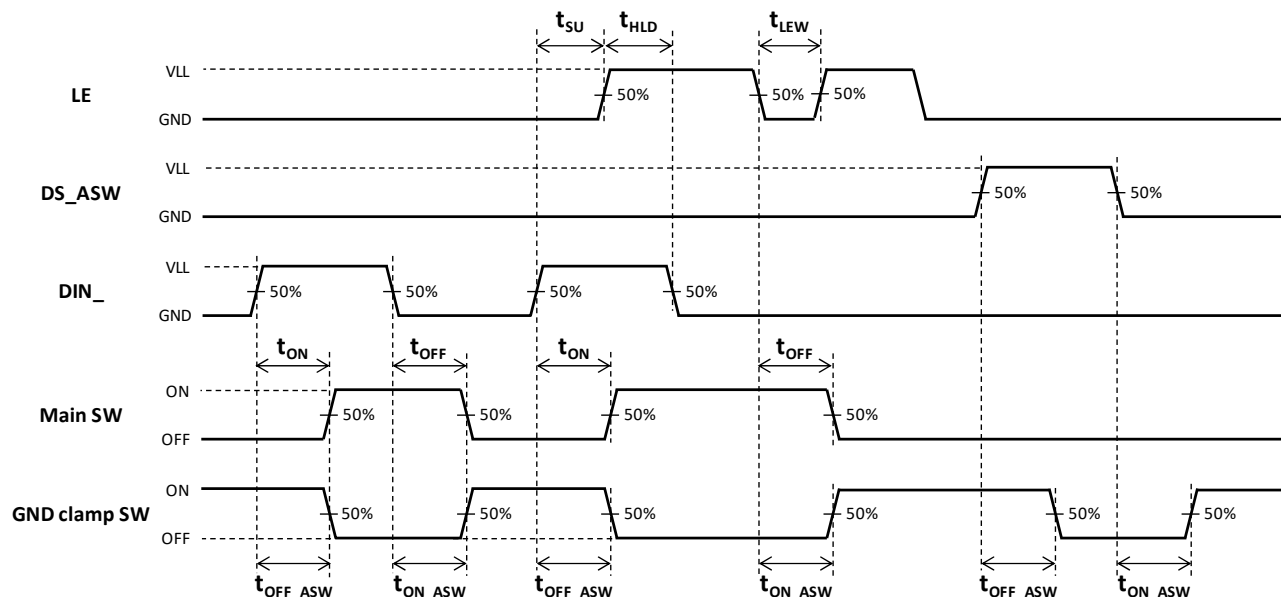


Fig.3 Logic Timing

5. Test Circuits

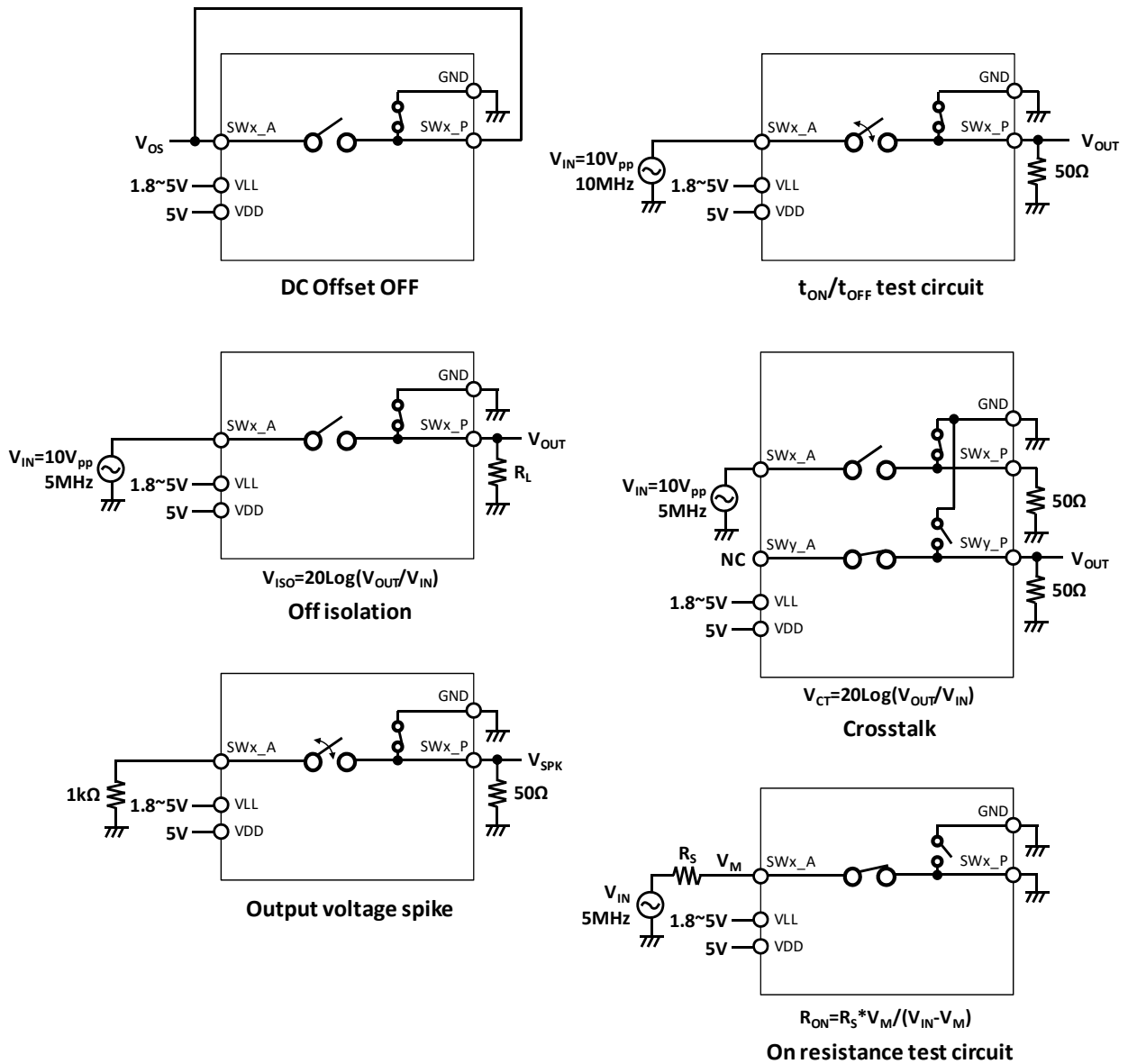


Fig.4 Test Circuits

6. Truth Table

Table 5 Truth table

| Logic Inputs | | | | | | Analog Switch State | | | | | | | |
|--------------|--------|------|------|------|------|---------------------|----------|-------------|----------|------------|----------|------------|----------|
| LE | DS_ASW | DIN4 | DIN3 | DIN2 | DIN1 | SW13 to SW16 | | SW9 to SW12 | | SW5 to SW8 | | SW1 to SW4 | |
| | | | | | | Main SW | Clamp SW | Main SW | Clamp SW | Main SW | Clamp SW | Main SW | Clamp SW |
| 0 | 0 | 0 | 0 | 0 | 0 | OFF | ON | OFF | ON | OFF | ON | OFF | ON |
| 0 | 0 | 0 | 0 | 0 | 1 | OFF | ON | OFF | ON | OFF | ON | ON | OFF |
| 0 | 0 | 0 | 0 | 1 | 0 | OFF | ON | OFF | ON | ON | OFF | OFF | ON |
| 0 | 0 | 0 | 0 | 1 | 1 | OFF | ON | OFF | ON | ON | OFF | ON | OFF |
| 0 | 0 | 0 | 1 | 0 | 0 | OFF | ON | ON | OFF | OFF | ON | OFF | ON |
| 0 | 0 | 0 | 1 | 0 | 1 | OFF | ON | ON | OFF | OFF | ON | ON | OFF |
| 0 | 0 | 0 | 1 | 1 | 0 | OFF | ON | ON | OFF | ON | OFF | OFF | ON |
| 0 | 0 | 0 | 1 | 1 | 1 | OFF | ON | ON | OFF | ON | OFF | ON | OFF |
| 0 | 0 | 1 | 0 | 0 | 0 | ON | OFF | OFF | ON | OFF | ON | OFF | ON |
| 0 | 0 | 1 | 0 | 0 | 1 | ON | OFF | OFF | ON | OFF | ON | ON | OFF |
| 0 | 0 | 1 | 0 | 1 | 0 | ON | OFF | OFF | ON | ON | OFF | OFF | ON |
| 0 | 0 | 1 | 0 | 1 | 1 | ON | OFF | OFF | ON | ON | OFF | ON | OFF |
| 0 | 0 | 1 | 1 | 0 | 0 | ON | OFF | ON | OFF | OFF | ON | OFF | ON |
| 0 | 0 | 1 | 1 | 0 | 1 | ON | OFF | ON | OFF | OFF | ON | ON | OFF |
| 0 | 0 | 1 | 1 | 1 | 0 | ON | OFF | ON | OFF | ON | OFF | OFF | ON |
| 0 | 0 | 1 | 1 | 1 | 1 | ON | OFF | ON | OFF | ON | OFF | ON | OFF |
| 0 | 1 | 0 | 0 | 0 | 0 | OFF | OFF | OFF | OFF | OFF | OFF | OFF | OFF |
| 0 | 1 | 0 | 0 | 0 | 1 | OFF | OFF | OFF | OFF | OFF | OFF | ON | OFF |
| 0 | 1 | 0 | 0 | 1 | 0 | OFF | OFF | OFF | OFF | ON | OFF | OFF | OFF |
| 0 | 1 | 0 | 0 | 1 | 1 | OFF | OFF | OFF | OFF | ON | OFF | ON | OFF |
| 0 | 1 | 0 | 1 | 0 | 0 | OFF | OFF | ON | OFF | OFF | OFF | OFF | OFF |
| 0 | 1 | 0 | 1 | 0 | 1 | OFF | OFF | ON | OFF | OFF | OFF | ON | OFF |
| 0 | 1 | 0 | 1 | 1 | 0 | OFF | OFF | ON | OFF | ON | OFF | OFF | OFF |
| 0 | 1 | 0 | 1 | 1 | 1 | OFF | OFF | ON | OFF | ON | OFF | ON | OFF |
| 0 | 1 | 1 | 0 | 0 | 0 | ON | OFF | OFF | OFF | OFF | OFF | OFF | OFF |
| 0 | 1 | 1 | 0 | 0 | 1 | ON | OFF | OFF | OFF | OFF | OFF | ON | OFF |
| 0 | 1 | 1 | 0 | 1 | 0 | ON | OFF | OFF | OFF | ON | OFF | OFF | OFF |
| 0 | 1 | 1 | 0 | 1 | 1 | ON | OFF | OFF | OFF | ON | OFF | ON | OFF |
| 0 | 1 | 1 | 1 | 0 | 0 | ON | OFF | ON | OFF | OFF | OFF | OFF | OFF |
| 0 | 1 | 1 | 1 | 0 | 1 | ON | OFF | ON | OFF | OFF | OFF | ON | OFF |
| 0 | 1 | 1 | 1 | 1 | 0 | ON | OFF | ON | OFF | ON | OFF | OFF | OFF |
| 0 | 1 | 1 | 1 | 1 | 1 | ON | OFF | ON | OFF | ON | OFF | ON | OFF |
| 1 | X | X | X | X | X | Hold Previous State | | | | | | | |

7. Pin Configuration

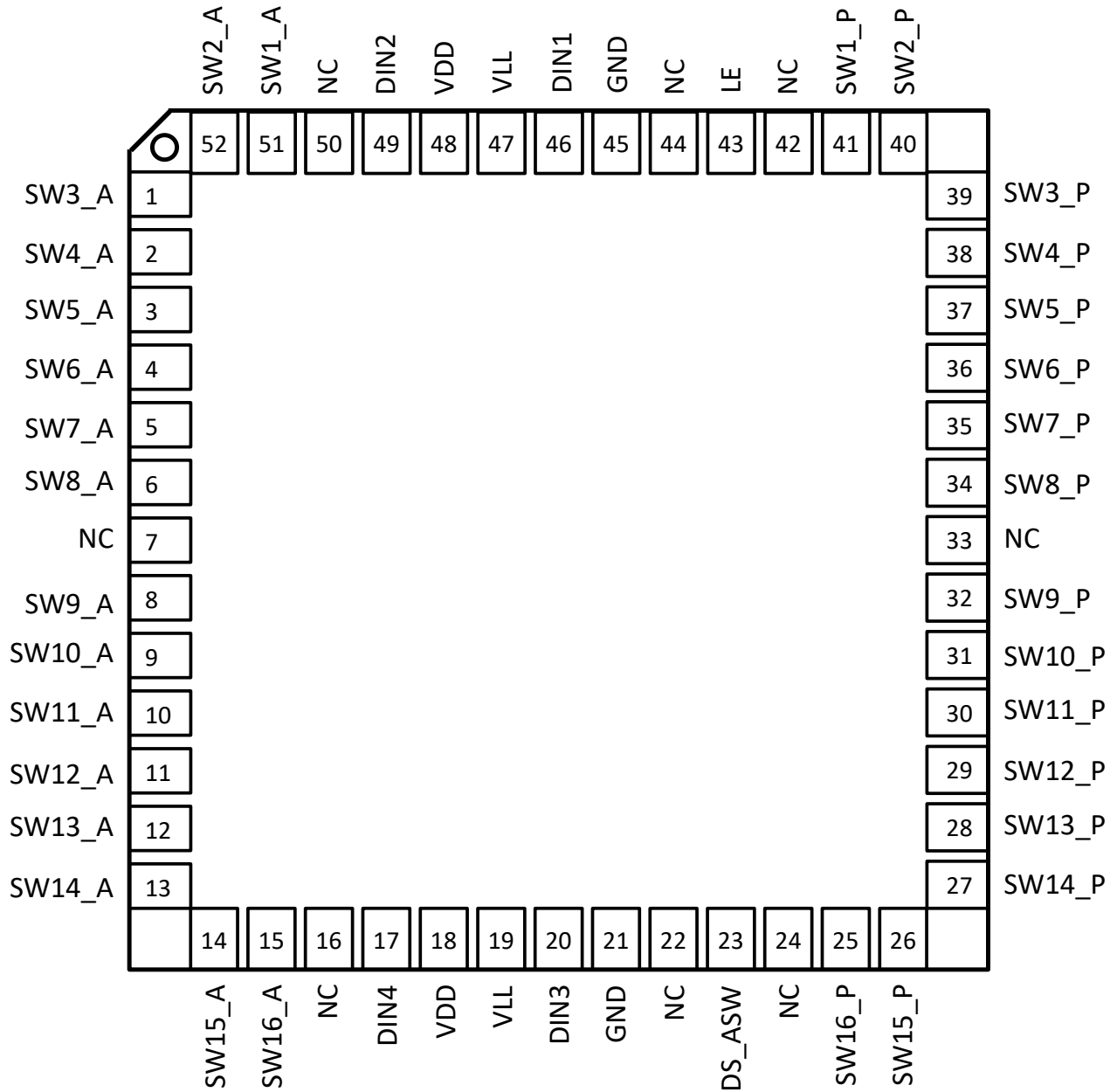


Fig.5 Pin Configuration

Table 6 Pin Configuration

| Pin# | Pin Name | I/O | Function |
|------|----------|-----|---|
| 1 | SW3_A | I/O | Analog switch terminal 3 (AFE side) |
| 2 | SW4_A | I/O | Analog switch terminal 4 (AFE side) |
| 3 | SW5_A | I/O | Analog switch terminal 5 (AFE side) |
| 4 | SW6_A | I/O | Analog switch terminal 6 (AFE side) |
| 5 | SW7_A | I/O | Analog switch terminal 7 (AFE side) |
| 6 | SW8_A | I/O | Analog switch terminal 8 (AFE side) |
| 7 | NC | - | No connection (Not internally connected) |
| 8 | SW9_A | I/O | Analog switch terminal 9 (AFE side) |
| 9 | SW10_A | I/O | Analog switch terminal 10 (AFE side) |
| 10 | SW11_A | I/O | Analog switch terminal 11 (AFE side) |
| 11 | SW12_A | I/O | Analog switch terminal 12 (AFE side) |
| 12 | SW13_A | I/O | Analog switch terminal 13 (AFE side) |
| 13 | SW14_A | I/O | Analog switch terminal 14 (AFE side) |
| 14 | SW15_A | I/O | Analog switch terminal 15 (AFE side) |
| 15 | SW16_A | I/O | Analog switch terminal 16 (AFE side) |
| 16 | NC | - | No connection (Not internally connected) |
| 17 | DIN4 | I | Data input 4 for SW13 to SW16, Hi=ON, Low=OFF |
| 18 | VDD | - | Positive low voltage power supply (+5V) |
| 19 | VLL | - | Positive voltage supply of low voltage interface (+1.8V~+5V) |
| 20 | DIN3 | I | Data input 3 for SW9 to SW12, Hi=ON, Low=OFF |
| 21 | GND | - | Drive power ground (0V) |
| 22 | NC | - | No connection (Not internally connected) |
| 23 | DS_ASW | I | GND clamp control, Hi=always disabled, Low=main switches and GND clamp switches are alternately turned on and off |
| 24 | NC | - | No connection (Not internally connected) |
| 25 | SW16_P | I/O | Analog switch terminal 16 (Probe side) |
| 26 | SW15_P | I/O | Analog switch terminal 15 (Probe side) |

Table 6 Pin Configuration (cont.)

| Pin# | Pin Name | I/O | Function |
|------|----------|-----|--|
| 27 | SW14_P | I/O | Analog switch terminal 14 (Probe side) |
| 28 | SW13_P | I/O | Analog switch terminal 13 (Probe side) |
| 29 | SW12_P | I/O | Analog switch terminal 12 (Probe side) |
| 30 | SW11_P | I/O | Analog switch terminal 11 (Probe side) |
| 31 | SW10_P | I/O | Analog switch terminal 10 (Probe side) |
| 32 | SW9_P | I/O | Analog switch terminal 9 (Probe side) |
| 33 | NC | - | No connection (Not internally connected) |
| 34 | SW8_P | I/O | Analog switch terminal 8 (Probe side) |
| 35 | SW7_P | I/O | Analog switch terminal 7 (Probe side) |
| 36 | SW6_P | I/O | Analog switch terminal 6 (Probe side) |
| 37 | SW5_P | I/O | Analog switch terminal 5 (Probe side) |
| 38 | SW4_P | I/O | Analog switch terminal 4 (Probe side) |
| 39 | SW3_P | I/O | Analog switch terminal 3 (Probe side) |
| 40 | SW2_P | I/O | Analog switch terminal 2 (Probe side) |
| 41 | SW1_P | I/O | Analog switch terminal 1 (Probe side) |
| 42 | NC | - | No connection (Not internally connected) |
| 43 | LE | I | Latch enable input, Hi=Hold data, Low=Latch data input |
| 44 | NC | - | No connection (Not internally connected) |
| 45 | GND | - | Drive power ground (0V) |
| 46 | DIN1 | I | Data input 1 for SW1 to SW4, Hi=ON, Low=OFF |
| 47 | VLL | - | Positive voltage supply of low voltage interface (+1.8V~+5V) |
| 48 | VDD | - | Positive low voltage power supply (+5V) |
| 49 | DIN2 | I | Data input 2 for SW5 to SW8, Hi=ON, Low=OFF |
| 50 | NC | - | No connection (Not internally connected) |
| 51 | SW1_A | I/O | Analog switch terminal 1 (AFE side) |
| 52 | SW2_A | I/O | Analog switch terminal 2 (AFE side) |

8. Package Outline

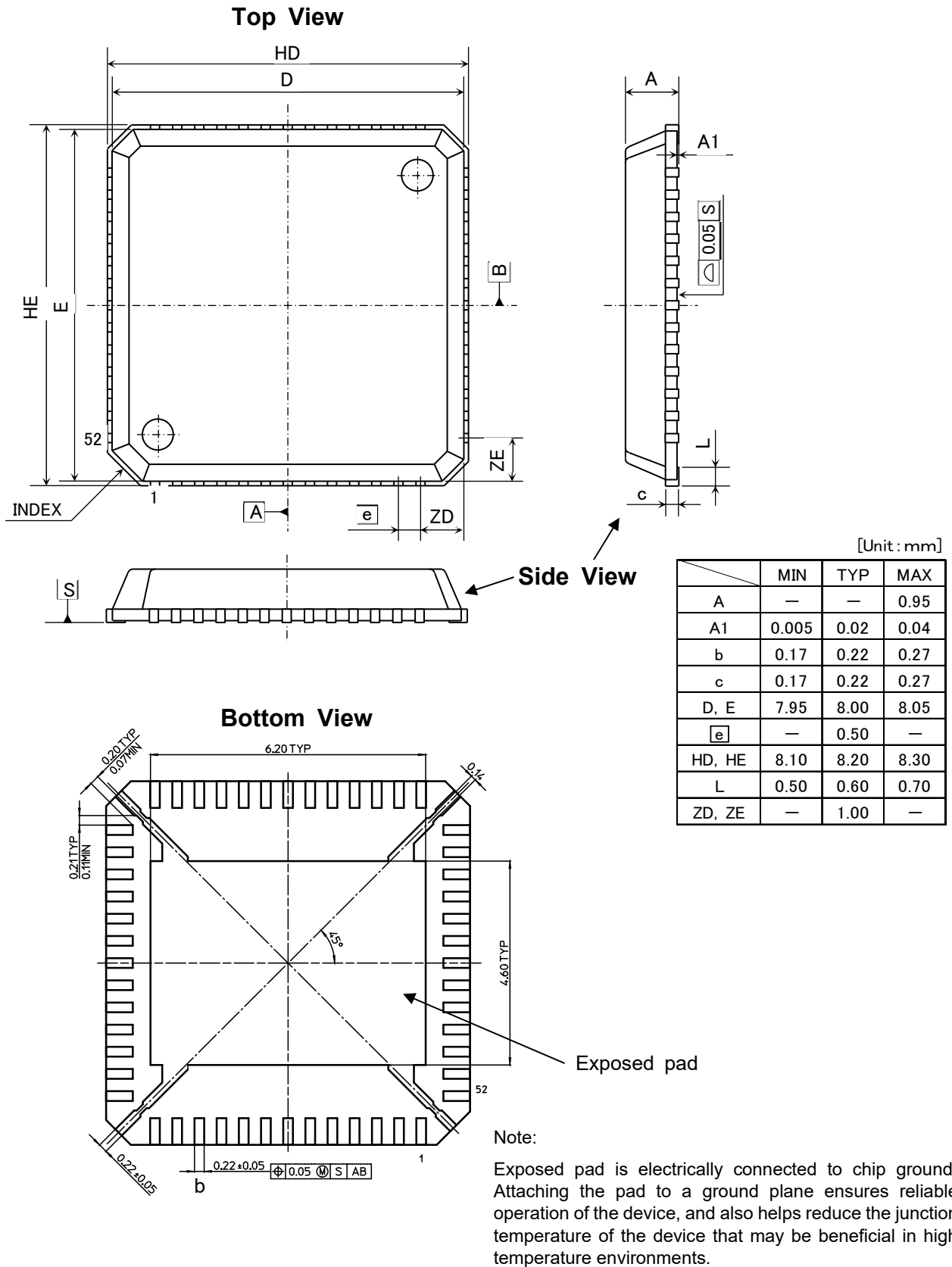
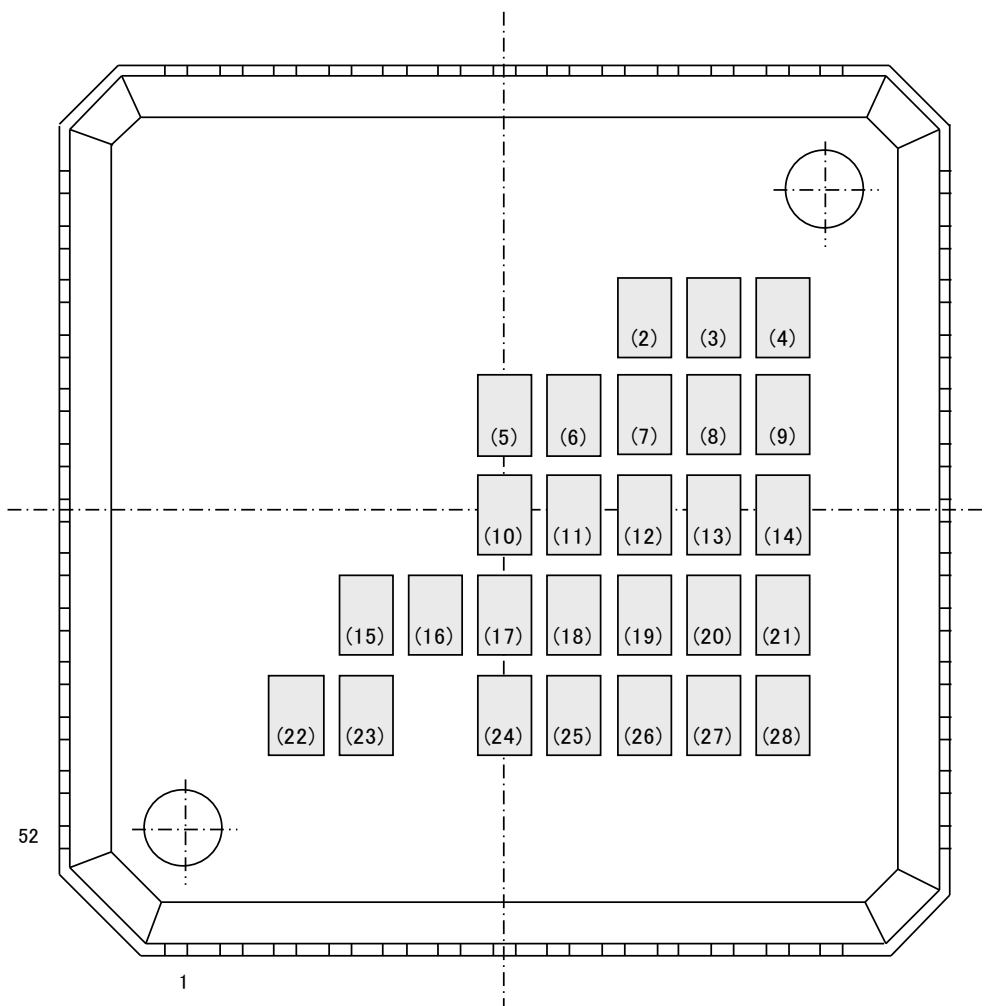


Fig.6 Package Outline (52-Lead QFN Package)

9. Package Marking



| No. | Code |
|-----------|--|
| (2) | Year sealed : the last one digit of the year |
| (3) | Month sealed : A~M (exc. "I") in the order of Jan. to Dec. |
| (4) | Week sealed : 1~5 |
| (5)~(9) | HDL6M |
| (10)~(14) | 6502B (product name) |
| (15)~(23) | Quality control code |
| (24)~(28) | Country of origin |

Fig.7 Package Marking

10. Transport Media, Quantity

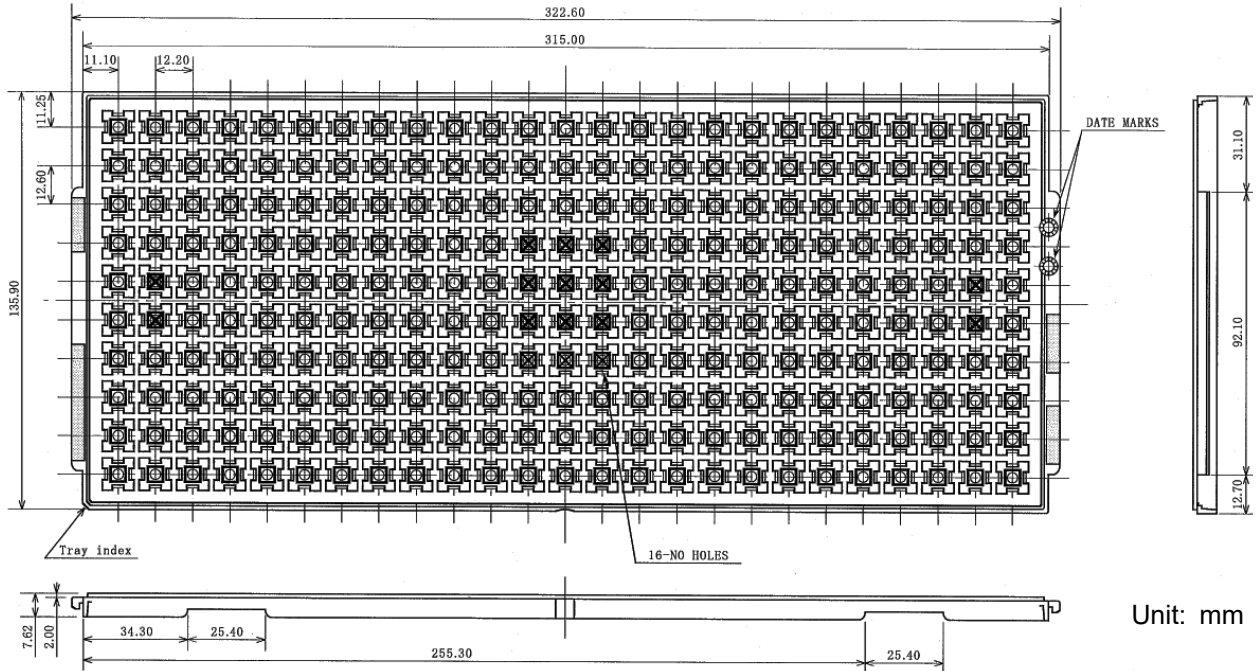
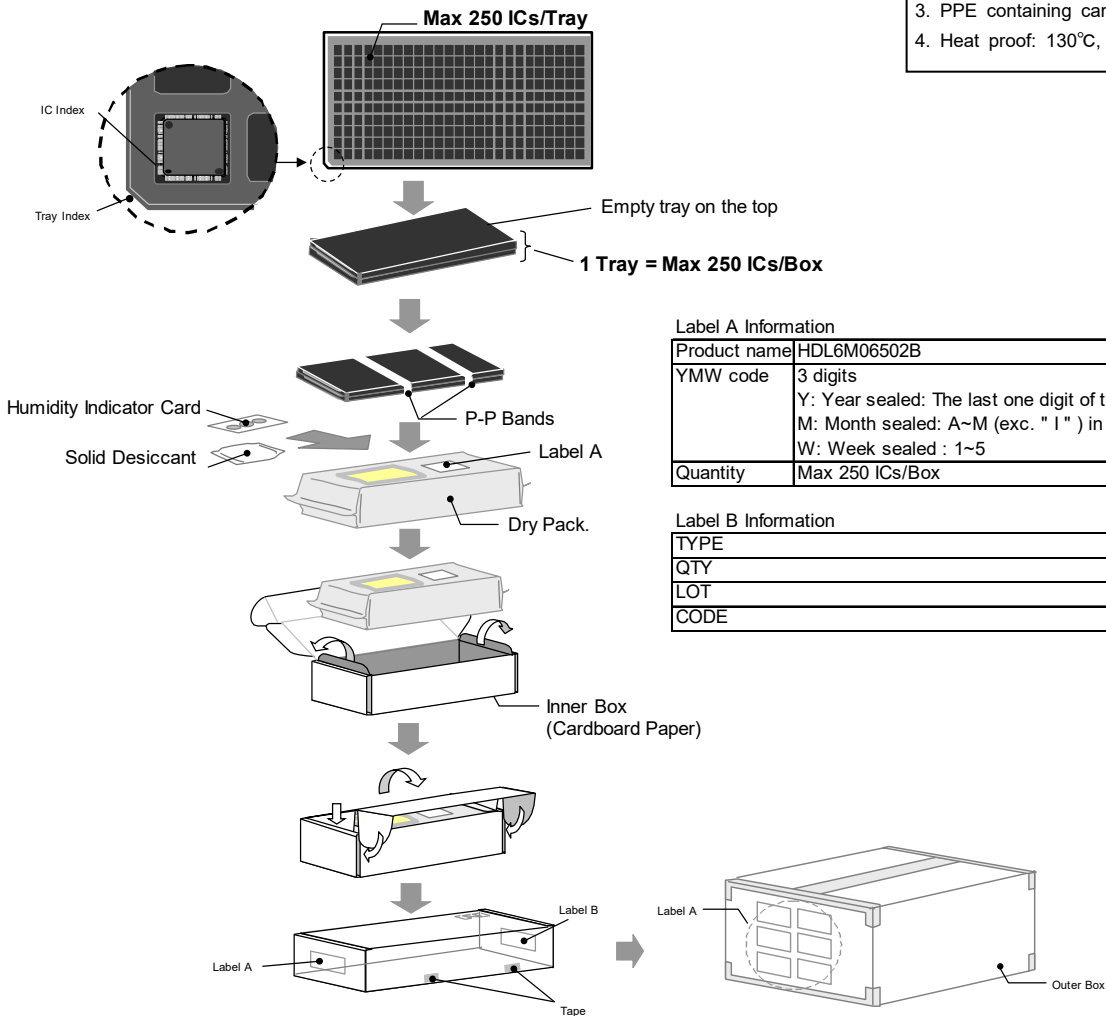


Fig.8 IC Tray Outline

1. Max 250 IC/Tray
2. 16 positions without holes (*)
3. PPE containing carbon and static proof
4. Heat proof: 130°C, 24hr



Label A Information

| | |
|--------------|--|
| Product name | HDL6M06502B |
| YMW code | 3 digits Y: Year sealed: The last one digit of the year M: Month sealed: A~M (exc. "I") in the order of Jan. to Dec. W: Week sealed : 1~5 |
| Quantity | Max 250 ICs/Box |

Label B Information

| | |
|------|--|
| TYPE | |
| QTY | |
| LOT | |
| CODE | |

Fig.9 Transport Media, Quantity

11. Mounting, Storage

11.1 Mounting Pad Design Example

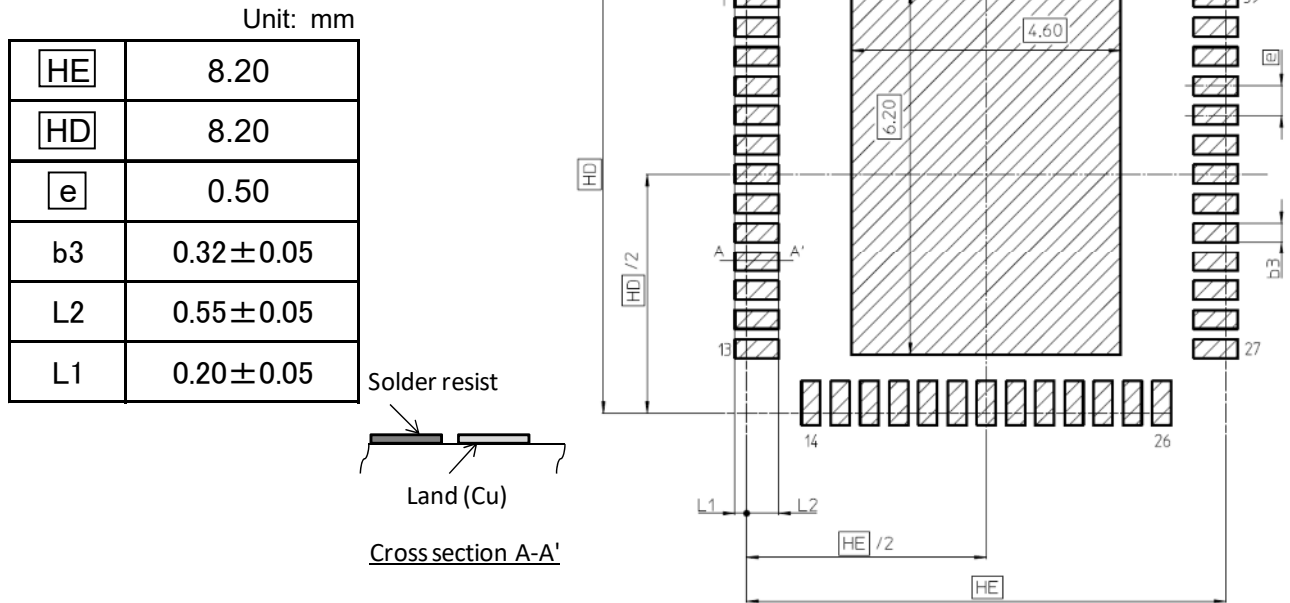


Fig.10 Mounting Pad Design Example

11.2 Storage Conditions

11.2.1 The storage location should be kept at 5 to 35 °C and 40 to 70% relative humidity. Keeping in a dry box is recommended. Moisture-proof property is assured for 12 months from delivery date for sealed moisture-proof packing, while it is guaranteed for 7 days from unpacked date under the condition above.

11.2.2 When the storage conditions do not conform to those above or other conditions occur indicating moisture exposure, the ICs should be dried to avoid package cracks. A baking process at 125 °C lasting for 24 hours results in sufficient dehumidification. The baking is not allowed more than twice, and the ICs should be mounted within 7 days after initial baking or within 10 days of total exposure after the second dehumidification.

11.3 Reflow Conditions

Typical full heating methods such as Infrared (IR), Hot air, and N2 reflow process are applicable. IR/Air reflow heating conditions are shown below.

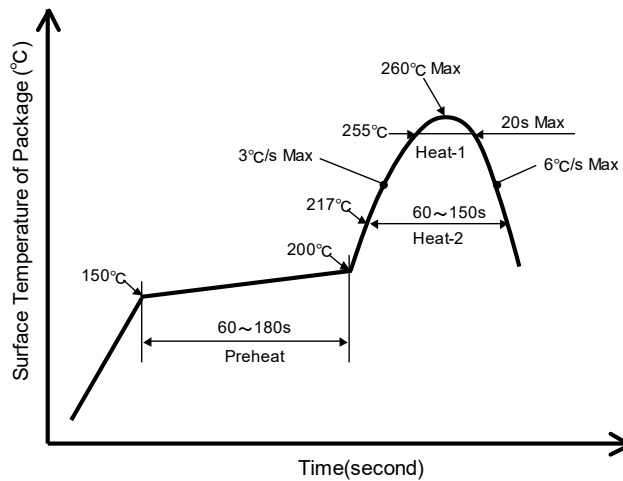


Fig.11 IR/Air Reflow Heating Conditions

12. Inspection

Hundred percent inspections shall be conducted on electrical characteristics.

13. Important Notice

- 13.1 ABLIC Inc. warrants performance of its hardware products (hereinafter called "products") to the specifications applicable at the time of sale in accordance with the Product Specification. Testing and other quality control techniques are utilized to the extent ABLIC Inc. needs to meet specifications described in the Product Specification. Specific testing of all parameters of each device is not necessarily performed, except those mandated by related laws and/or regulations.
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14. Cautions

- 14.1 Customers are advised to follow the cautions below to protect products from damage caused by electrical static discharge (ESD).
 - 14.1.1 Material of container or any device to carry products should be free from ESD, which may be caused by vibration while transportation. It is recommended that electric-conductive container or aluminum sheet be used as an effective countermeasure.
 - 14.1.2 Those who touch products such as work platform, machine, measurement/test equipment should be grounded.
 - 14.1.3 Those who deal with products should be grounded through a large series impedance around 100kΩ to 1MΩ.
 - 14.1.4 Prevent friction with other materials made with high polymer.
 - 14.1.5 Prevent vibration or friction when carrying the printed circuit board (PCB) where products are mounted. To short circuit terminals is a recommended countermeasure to keep the same electric potential on the PCB.
 - 14.1.6 Avoid dealing with or storing products in an extremely arid environment.
- 14.2 "Absolute maximum ratings" should never be exceeded during use regardless of any change in external conditions. Otherwise, products may be damaged or destroyed. In no event shall ABLIC Inc. be liable for any failure in products or any secondary damage resulting from use at a value exceeding the absolute maximum ratings.
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- 14.4 Products may experience failures or malfunction in poor surroundings, such as electrical leakage in products due to long-term use in high humidity, malfunctioning or permanent damage due to chemical reaction of products in corrosive environment or due to discharge by strongly charged object near products or due to excessive mechanical shock. To use products in radiation environment is not assumed. To use products near material easy to ignite may cause a fire due to its flammable package. Avoid using products in such environment or take appropriate countermeasures depending on the environment.
- 14.5 Products are not designed, manufactured, or warranted to be suitable for use where extremely high reliability is required (such as use in nuclear power control, aerospace and aviation, traffic equipment, life-support-related medical equipment, fuel control equipment and various kinds of safety equipment). Inclusion of products in such application shall be fully at the risk of customers. ABLIC Inc. assumes no liability for applications assistance, customer product design, or performance.

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